FATIC characterization (FAst Timing Integrated Circuit)

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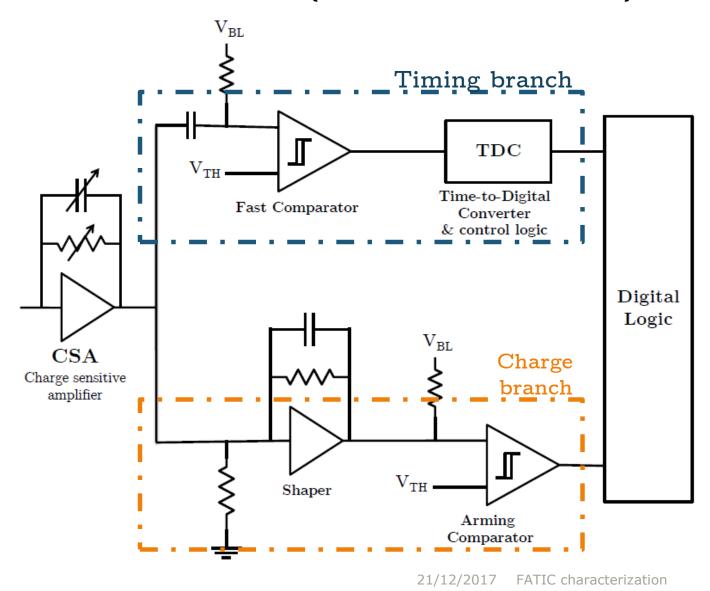


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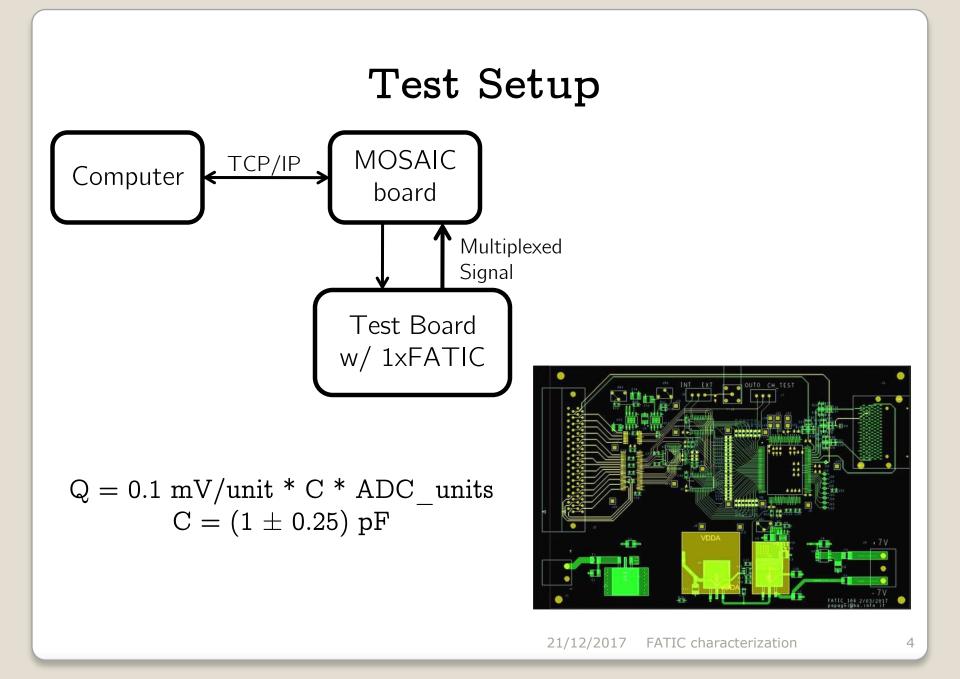
DO MORO

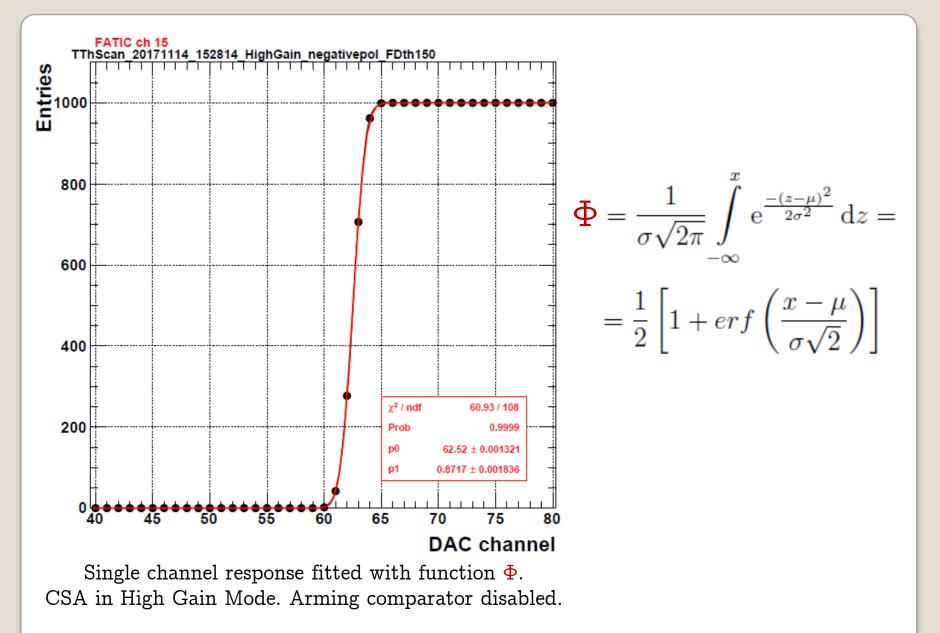
Schematic (single channel)



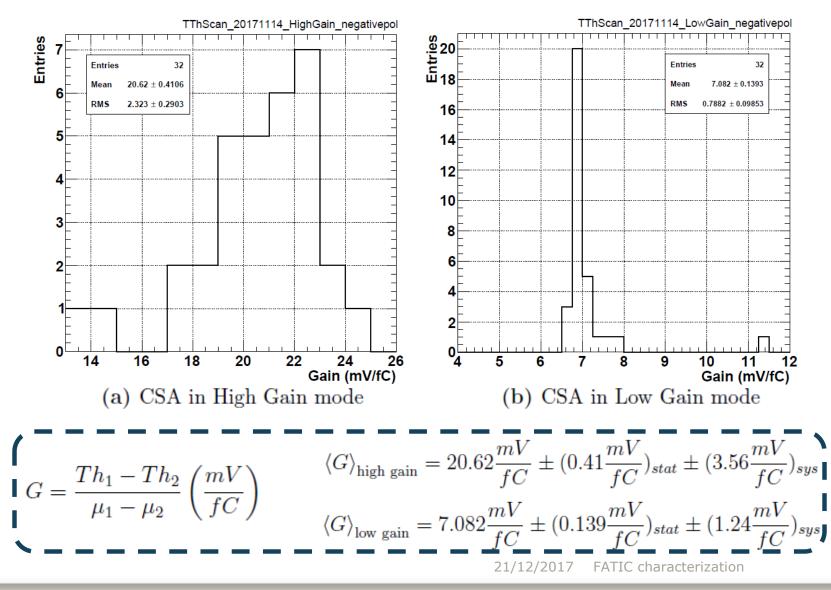
CSA		TDC	
Peaking time*	7.3 ns	Resolution	5-bit fine / 16-bit coarse
Time jitter*	300 ps @ 1 fC input charge	Reference Clock	320 MHz
ENC*	$18.2e^{-*Cin} (pF) + 235.5e^{-}$	Time resolution	100 ps
Current Cunsuption*	1.3 mA	Shaper	
Signal Polarity	positive & negative	Peaking time	100 ns
Gain	High gain mode: 50mV/fC	Fast Comparator	
	Low gain mode: 10 mV/fC	Threshold	[0 - 76.5]ke-, step 300e-
*simulation in high gain mode w/ $\mathrm{Cin}=15~\mathrm{pF}$		Arming Comparator	
		Threshold	[0 - 58.65]ke-, step 230e-

Table 1.1: FATIC features

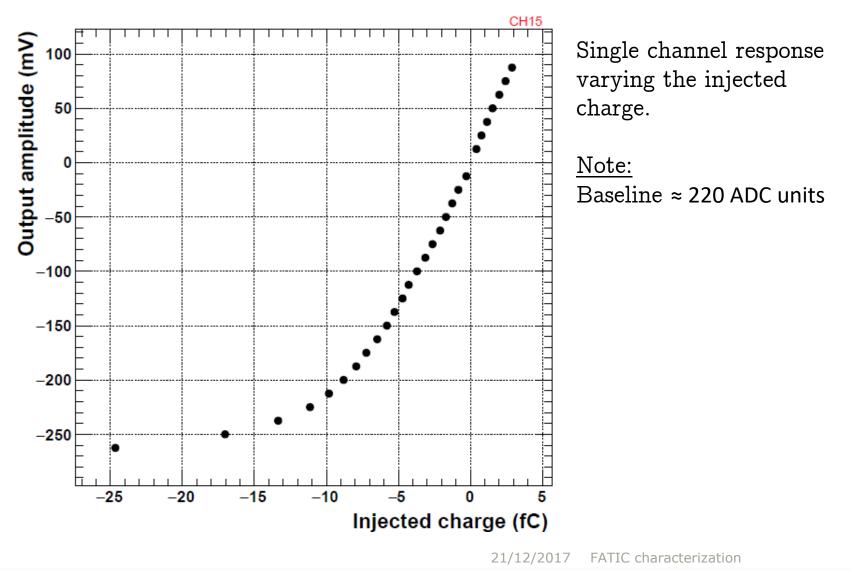




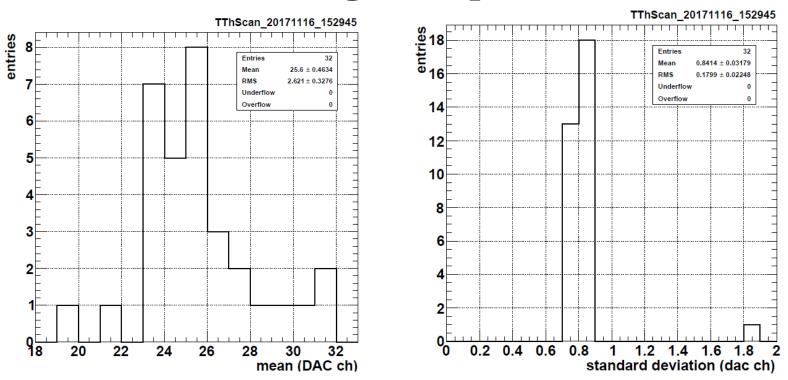
CSA Gain

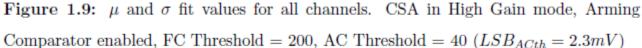




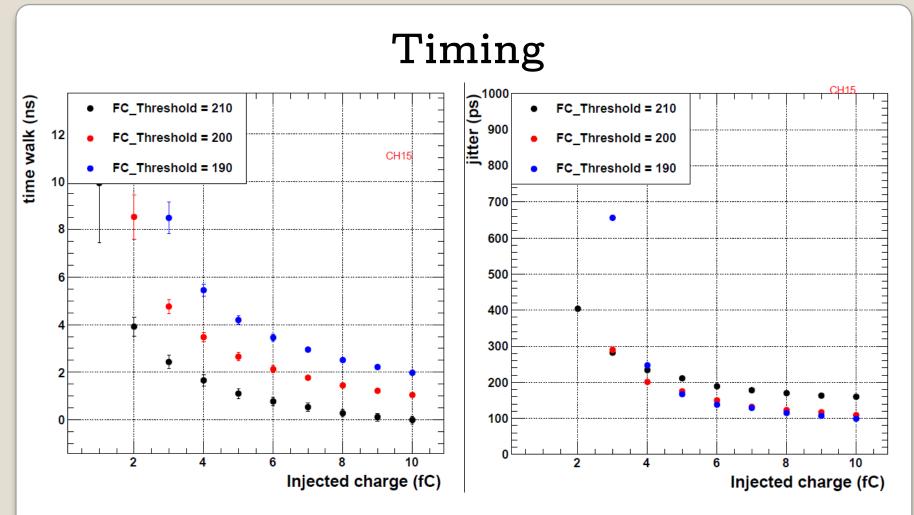


Arming comparator





$$\begin{split} \sigma_{\text{timing}} &= 1.026 \pm 0.045\\ \sigma_{\text{arming}} &= 0.841 \pm 0.032 \end{split}$$
 % ENC_{reduction} = [$\sigma_{\text{timing}} - \sigma_{\text{arming}}$] / $\sigma_{\text{timing}} \approx 18\%$



- Input trigger and the fast-OR signal sent to the scope
- Average delay = time walk
- Delay std deviation = time jitter

Upgrade ideas for FATIC v.2

- Internal circuit for threshold matching
- Investigate CSA gain (lower than expected)
- Symmetric dynamic for positive and negative signals